TOSHIBA Transistor Silicon PNP Triple Diffused Type

2SB1411

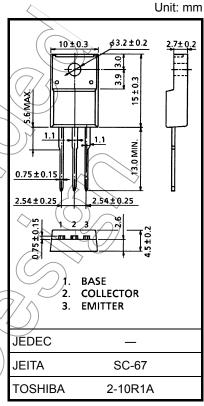
Switching Applications

Hammer Drive, Pulse Motor Drive Applications

- High DC current gain: $h_{FE} = 1500$ (min) ($V_{CE} = -3$ V, $I_{C} = -1$ A)
- Low saturation voltage: $V_{CE (sat)} = -1.5 \text{ V (max) (IC} = -1 \text{ A)}$

Absolute Maximum Ratings (Tc = 25°C)

| | | | | 1/ | |
|-----------------------------|-----------|---------------------|------------|----------------|--|
| Characteristics | | Symbol | Rating | Unit | |
| Collector-base voltage | | V_{CBO} | -100 | (/y) | |
| Collector-emitter voltage | | V _{CEO} | -100 | A | |
| Emitter-base voltage | | V _{EBO} | -7 | y | |
| Collector current | DC | IC | ~2 | ⇒ _A | |
| | Peak | I _{CP} | 73 | , A | |
| Base current | | ΙΒ | -0.5 | A | |
| Collector power dissipation | Ta = 25°C | P _C | 2.0 | W | |
| | Tc = 25°C | | 20 | | |
| Junction temperature | | $T_{j} \Big(\Big($ | 150 | °Ç | |
| Storage temperature range | | Tstg | -55 to 150 | °C | |



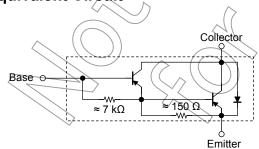
Weight: 1.7 g (typ.)

Note: Using continuously under heavy loads (e.g. the application of high

temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

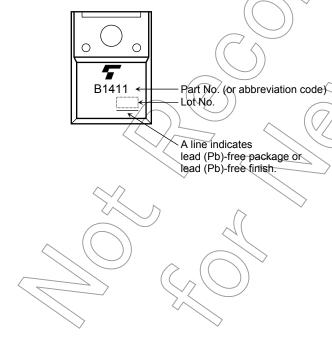
Equivalent Circuit

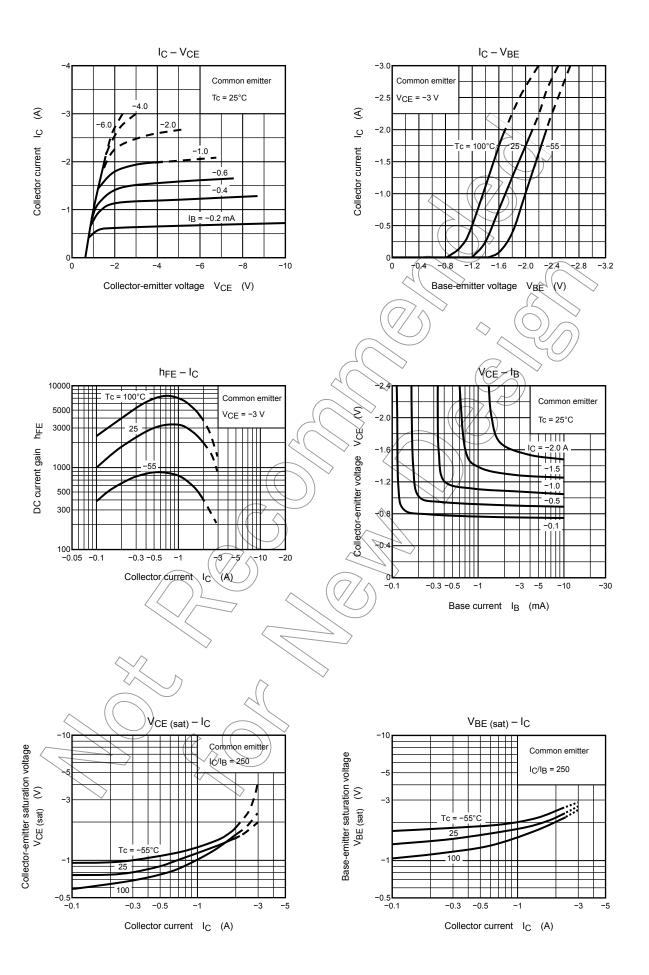


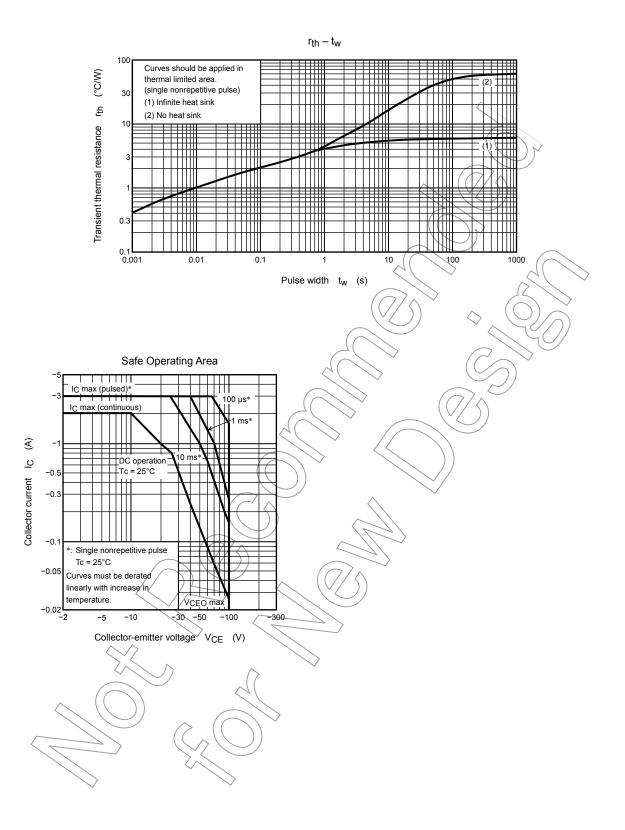
Electrical Characteristics (Tc = 25°C)

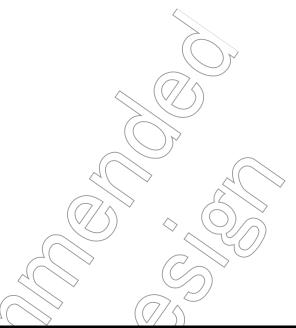
| Chara | acteristics | Symbol | Test Condition | Min | Тур. | Max | Unit |
|--------------------------------------|--------------|---------------------------|---|--------------|------|---------------|------|
| Collector cut-off current | | I _{CBO} | V _{CB} = -100 V, I _E = 0 | _ | _ | -100 | μΑ |
| Emitter cut-off current | | I _{EBO} | V _{EB} = -6 V, I _C = 0 | - | _ | -2.5 | mA |
| Collector-emitter breakdown voltage | | V (BR) CEO | $I_C = -30 \text{ mA}, I_B = 0$ | -100 | _ | _ | V |
| DC current gain | | h _{FE (1)} | V _{CE} = -3 V, I _C = -1 A | 1500 | _ | 15000 | |
| | | h _{FE (2)} | V _{CE} = -3 V, I _C = -2 A | 1000 |) >- | _ | |
| Collector-emitter saturation voltage | | V _{CE} (sat) (1) | I _C = -1 A, I _B = -2 mA |) | _ | -1.5 | V |
| | | V _{CE} (sat) (2) | I _C = -2 A, I _B = -8 mA | $\bigcirc)$ | _ | -2.5 | |
| Base-emitter saturation voltage | | V _{BE} (sat) | I _C = -1 A, I _B = -2 mA |) | _ | -2.2 | V |
| Switching time | Turn-on time | ton | Input B1 Wew 30 N | _ | 1.0 | / | μs |
| | Storage time | t _{stg} | | | 3.0 | <u>></u> – | |
| | Fall time | t _f | 20 μs -I _{B1} = I _{B2} = 2 mA, duty cycle ≤ 1% | | 2.0 | | |











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